



低功耗双通道数字隔离器

1 特性

- 适用于汽车电子 应用
- 下列性能符合 AEC-Q100 标准:
 - 器件温度 1 级: -40°C 至 $+125^{\circ}\text{C}$ 的环境工作温度范围
 - 器件 HBM ESD 分类等级 H3A
 - 器件 CDM ESD 分类等级 C4
- 传播延迟低于 20ns
- 低功耗
- 安全及管理批准:
 - 符合 VDE 标准的 4242V_{PK} 隔离, 符合 UL 1577 标准的 2.5kVrms 隔离, 通过 IEC 60950-1 和 IEC 61010-1 终端设备标准验证的 CSA
- 50kV/ μs 瞬态抗扰度典型值
- 工作电压和逻辑电平范围为 3.3V 至 5V

2 应用

- 光耦合器替代产品
 - 伺服器控制接口
 - 电机控制
 - 电源
 - 电池组

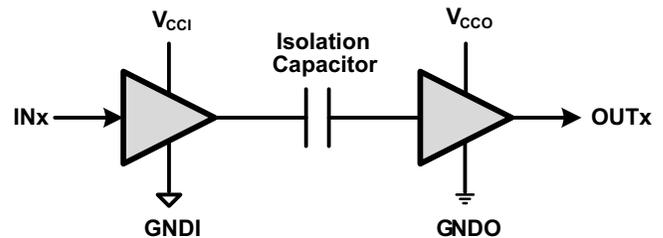
3 说明

ISO7421E-Q1 可提供符合 UL 标准、持续时间为 1 分钟的高达 2.5kVrms 的双电隔离。这个数字隔离器在一个双向配置中有两个隔离通道。每个隔离通道都有一个由二氧化硅 (SiO₂) 绝缘隔栅分开的逻辑输入和输出缓冲器。与隔离电源配合使用, 这些器件可防止数据总线或者其它电路上的噪声电流进入本地接地并且干扰或损坏敏感电路。

此器件有 TTL 输入阈值并要求两个电源电压, 3.3V 或者 5V, 或者二者的任意组合。当由一个 3.3V 电源供电时, 所有输入为 5V 耐压。

请注意: ISO7421E-Q50 额定信号传输速率高达 50Mbps。由于它们的快速响应时间, 在大多数情况下, 这些器件还将发送带有更短脉冲宽度的数据。如果需要, 设计人员应该增加外部滤波来去除输入脉冲持续时间 $< 20\text{ns}$ 的寄生信号。

简化原理图



- (1) V_{CCI} 和 GNDI 分别是输入通道的电源和接地连接引脚。
- (2) V_{CCO} 和 GNDO 分别是输出通道的电源和接地连接引脚。



4 Pin Configuration and Functions

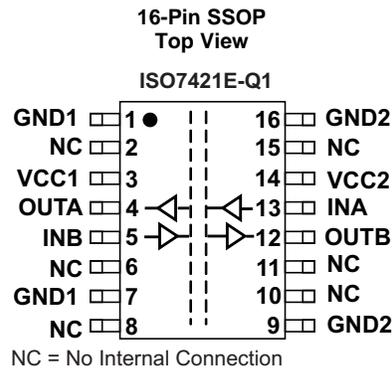


Table 1. Pin Functions

PIN		I/O	DESCRIPTION
NAME	ISO7421E-Q1		
INA	13	I	Input, channel A
INB	5	–	Input, channel B
GND1	1, 7	–	Ground connection for V_{CC1}
GND2	9, 16	O	Ground connection for V_{CC2}
OUTA	4	O	Output, channel A
OUTB	12	–	Output, channel B
V_{CC1}	14	–	Power supply, V_{CC1}
V_{CC2}	14	-	Power supply, V_{CC2}
NC	2, 6, 8, 10, 11, 15		No Connect Pin

4.1 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

4.1 Device Function Table

INPUT SIDE V_{CC} (V_{CCI}) ⁽¹⁾	OUTPUT SIDE V_{CC} (V_{CCO}) ⁽¹⁾	INPUT (IN) ⁽¹⁾	OUTPUT (OUT) ⁽¹⁾
PU	PU	H	H
		L	L
		Open	H
PD	PU	X	H

(1) PU = Powered Up ($V_{CC} \geq 3.15V$); PD = Powered Down ($V_{CC} \leq 2.4V$); X = Irrelevant; H = High Level; L = Low Level

4.2 Available Options

PRODUCT	RATED T_A	MARKED AS	ORDERING NUMBER
ISO7421E-Q1	-40°C to 125°C	ISO7421EQ	ISO7421EQDWRQ1

5 Absolute Maximum Ratings⁽¹⁾

		VALUE		UNIT		
		MIN	MAX			
V_{CC}	Supply voltage ⁽²⁾ , V_{CC1} , V_{CC2}	-0.5	6	V		
V_I	Voltage at IN, OUT	-0.5	$V_{CC} + 0.5$ ⁽³⁾	V		
I_O	Output Current		±15	mA		
ESD	Electrostatic discharge	Human Body Model	AEC-Q100 Classification Level H3A	All pins	4	kV
		Charged Device Model	AEC-Q100 Classification Level C4		1	kV
T_J	Maximum junction temperature		150		°C	

- (1) Stresses beyond those listed under [Absolute Maximum Ratings^{\(1\)}](#) may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under [Recommended Operating Conditions](#) is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values except differential I/O bus voltages are with respect to network ground terminal and are peak voltage values.
- (3) Maximum voltage must not exceed 6 V. A strongly driven input signal can weakly power the floating V_{CC} via an internal protection diode and cause undetermined output.

6 Thermal Information

THERMAL METRIC ⁽¹⁾		ISO7421E-Q1	UNITS
		DW (16 Pins)	
θ_{JA}	Junction-to-ambient thermal resistance	79.9	°C/W
$\theta_{Jc\text{top}}$	Junction-to-case (top) thermal resistance	44.6	
θ_{JB}	Junction-to-board thermal resistance	51.2	
ψ_{JT}	Junction-to-top characterization parameter	18.0	
ψ_{JB}	Junction-to-board characterization parameter	42.2	
$\theta_{Jc\text{bot}}$	Junction-to-case (bottom) thermal resistance	n/a	
P_D	Device power dissipation, $V_{CC1} = V_{CC2} = 5.25V$, $T_J = 150^\circ\text{C}$, $C_L = 15\text{ pF}$, Input a 0.5 MHz 50% duty cycle square wave	42	mW

- (1) 有关传统和新热指标的更多信息，请参见应用报告《半导体和 IC 封装热指标》（文献编号：SPRA953）。

7 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	TYP	MAX	UNIT
V _{CC1} , V _{CC2}	Supply voltage - 3.3V Operation	3.15	3.3	3.45	V
	Supply voltage - 5V Operation	4.75	5	5.25	
I _{OH}	High-level output current	-4			mA
I _{OL}	Low-level output current			4	mA
V _{IH}	High-level output voltage	2		V _{CC}	V
V _{IL}	Low-level output voltage	0		0.8	V
T _A	Ambient Temperature	-40		125	°C
T _J ⁽¹⁾	Junction temperature	-40		136	°C
1/t _{ui}	Signaling rate	0		50	Mbps
t _{ui}	Input pulse duration	1			μs

- (1) To maintain the recommended operating conditions for T_J, see the *Package Thermal Characteristics* table and the *Icc Equations* section of this data sheet

8 Electrical Characteristics

 V_{CC1} and V_{CC2} at 5 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V_{OH}	High-level output voltage	$I_{OH} = -4\text{ mA}$; See 图 1	$V_{CC} - 0.8$	4.6		V	
		$I_{OH} = -20\ \mu\text{A}$; See 图 1	$V_{CC} - 0.1$	5			
V_{OL}	Low-level output voltage	$I_{OL} = 4\text{ mA}$; See 图 1		0.2	0.4	V	
		$I_{OL} = 20\ \mu\text{A}$; See 图 1		0	0.1		
$V_{I(HYS)}$	Input threshold voltage hysteresis			400		mV	
I_{IH}	High-level input current	I_{Nx} at 0 V or V_{CC}			10	μA	
I_{IL}	Low-level input current		-10			μA	
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V; See 图 3	25	50		kV/ μs	
SUPPLY CURRENT (All inputs switching with square wave clock signal for dynamic I_{CC} measurement)							
I_{CC1}	Supply current for V_{CC1} and V_{CC2}	DC to 1 Mbps	DC Input: $V_I = V_{CC}$ or 0 V AC Input: $C_L = 15\text{ pF}$		2.3	3.6	mA
I_{CC2}					2.3	3.6	
I_{CC1}		10 Mbps	$C_L = 15\text{ pF}$		2.9	4.5	
I_{CC2}					2.9	4.5	
I_{CC1}		25 Mbps	$C_L = 15\text{ pF}$		4.3	6	
I_{CC2}					4.3	6	
I_{CC1}		50 Mbps	$C_L = 15\text{ pF}$		6	9.1	
I_{CC2}					6	9.1	

9 Switching Characteristics

 V_{CC1} and V_{CC2} at 5 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	See 图 1		9	14	ns
PWD ⁽¹⁾	Pulse width distortion $ t_{PHL} - t_{PLH} $			0.3	3.7	ns
$t_{sk(pp)}$	Part-to-part skew time				4.9	ns
$t_{sk(o)}$	Channel-to-channel output skew time				3.6	ns
t_r	Output signal rise time	See 图 1		1		ns
t_f	Output signal fall time			1		ns
t_{fs}	Fail-safe output delay time from input power loss	See 图 2		6		μs

(1) Also known as pulse skew.

10 Electrical Characteristics

 V_{CC1} at 5 V \pm 5%, V_{CC2} at 3.3 V \pm 5%, $T_A = -40^\circ\text{C}$ to 105 $^\circ\text{C}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -4$ mA; See 图 1	5-V side	$V_{CC} - 0.8$	4.6		V
			3.3-V side	$V_{CC} - 0.4$	3		
			$I_{OH} = -20$ μA ; See 图 1		$V_{CC} - 0.1$	V_{CC}	
V_{OL}	Low-level output voltage	$I_{OL} = 4$ mA; See 图 1			0.2	0.4	V
		$I_{OL} = 20$ μA ; See 图 1			0	0.1	
$V_{I(HYS)}$	Input threshold voltage hysteresis				400		mV
I_{IH}	High-level input current	I_{Nx} at 0 V or V_{CC}				10	μA
I_{IL}	Low-level input current			-10			μA
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V; See 图 3		25	40		kV/ μs
SUPPLY CURRENT (All inputs switching with square wave clock signal for dynamic I_{CC} measurement)							
I_{CC1}	Supply current for V_{CC1} and V_{CC2}	DC to 1 Mbps	DC Input: $V_I = V_{CC}$ or 0 V AC Input: $C_L = 15$ pF		2.3	3.6	mA
I_{CC2}					1.8	2.8	
I_{CC1}		10 Mbps	$C_L = 15$ pF		2.9	4.5	
I_{CC2}					2.2	3.2	
I_{CC1}		25 Mbps	$C_L = 15$ pF		4.3	6	
I_{CC2}					2.8	4.1	
I_{CC1}		50 Mbps	$C_L = 15$ pF		6	9.1	
I_{CC2}					3.8	5.8	

11 Switching Characteristics

 V_{CC1} at 5 V \pm 5%, V_{CC2} at 3.3 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125 $^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	See 图 1		10	17	ns
PWD ⁽¹⁾	Pulse width distortion $ t_{PHL} - t_{PLH} $			0.5	5.6	ns
$t_{sk(pp)}$	Part-to-part skew time				6.3	ns
$t_{sk(o)}$	Channel-to-channel output skew time				4	ns
t_r	Output signal rise time	See 图 1		2		ns
t_f	Output signal fall time			2		ns
t_{fs}	Fail-safe output delay time from input power loss	See 图 2		6		μs

(1) Also known as pulse skew.

12 Electrical Characteristics

 V_{CC1} at 3.3 V \pm 5%, V_{CC2} at 5 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125 $^\circ\text{C}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -4$ mA; See 图 1	5-V side	$V_{CC} - 0.8$	4.6		V
			3.3-V side	$V_{CC} - 0.4$	3		
		$I_{OH} = -20$ μA ; See 图 1	$V_{CC} - 0.1$	V_{CC}			
V_{OL}	Low-level output voltage	$I_{OL} = 4$ mA; See 图 1			0.2	0.4	V
		$I_{OL} = 20$ μA ; See 图 1			0	0.1	
$V_{I(HYS)}$	Input threshold voltage hysteresis				400		mV
I_{IH}	High-level input current	I_{Nx} at 0 V or V_{CC}				10	μA
I_{IL}	Low-level input current				-10		μA
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V; See 图 3		25	40		kV/ μs
SUPPLY CURRENT (All inputs switching with square wave clock signal for dynamic I_{CC} measurement)							
I_{CC1}	Supply current for V_{CC1} and V_{CC2}	DC to 1 Mbps	DC Input: $V_I = V_{CC}$ or 0 V AC Input: $C_L = 15$ pF		1.8	2.8	mA
I_{CC2}					2.3	3.6	
I_{CC1}		10 Mbps	$C_L = 15$ pF		2.2	3.2	
I_{CC2}					2.9	4.5	
I_{CC1}		25 Mbps	$C_L = 15$ pF		2.8	4.1	
I_{CC2}					4.3	6	
I_{CC1}		50 Mbps	$C_L = 15$ pF		3.8	5.8	
I_{CC2}					6	9.1	

13 Switching Characteristics

 V_{CC1} at 3.3 V \pm 5%, V_{CC2} at 5 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125 $^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	See 图 1		10	17	ns
PWD ⁽¹⁾	Pulse width distortion $ t_{PHL} - t_{PLH} $			0.5	4	ns
$t_{sk(pp)}$	Part-to-part skew time				8.5	ns
$t_{sk(o)}$	Channel-to-channel output skew time				4	ns
t_r	Output signal rise time	See 图 1		2		ns
t_f	Output signal fall time			2		ns
t_{fs}	Fail-safe output delay time from input power loss	See 图 2		6		μs

(1) Also known as pulse skew.

14 Electrical Characteristics

 V_{CC1} and V_{CC2} at 3.3 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V_{OH}	High-level output voltage	$I_{OH} = -4$ mA; See 图 1	$V_{CC} - 0.4$	3		V	
		$I_{OH} = -20$ μA ; See 图 1	$V_{CC} - 0.1$	3.3			
V_{OL}	Low-level output voltage	$I_{OL} = 4$ mA; See 图 1		0.2	0.4	V	
		$I_{OL} = 20$ μA ; See 图 1		0	0.1		
$V_{I(HYS)}$	Input threshold voltage hysteresis			400		mV	
I_{IH}	High-level input current	I_{Nx} at 0 V or V_{CC}				μA	
I_{IL}	Low-level input current		-10			μA	
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V; See 图 3	25	40		kV/ μs	
SUPPLY CURRENT (All inputs switching with square wave clock signal for dynamic I_{CC} measurement)							
I_{CC1}	Supply current for V_{CC1} and V_{CC2}	DC to 1 Mbps	DC Input: $V_I = V_{CC}$ or 0 V AC Input: $C_L = 15$ pF		1.8	2.8	mA
I_{CC2}					1.8	2.8	
I_{CC1}		10 Mbps	$C_L = 15$ pF		2.2	3.2	
I_{CC2}					2.2	3.2	
I_{CC1}		25 Mbps	$C_L = 15$ pF		2.8	4.1	
I_{CC2}					2.8	4.1	
I_{CC1}		50 Mbps	$C_L = 15$ pF		3.8	5.8	
I_{CC2}					3.8	5.8	

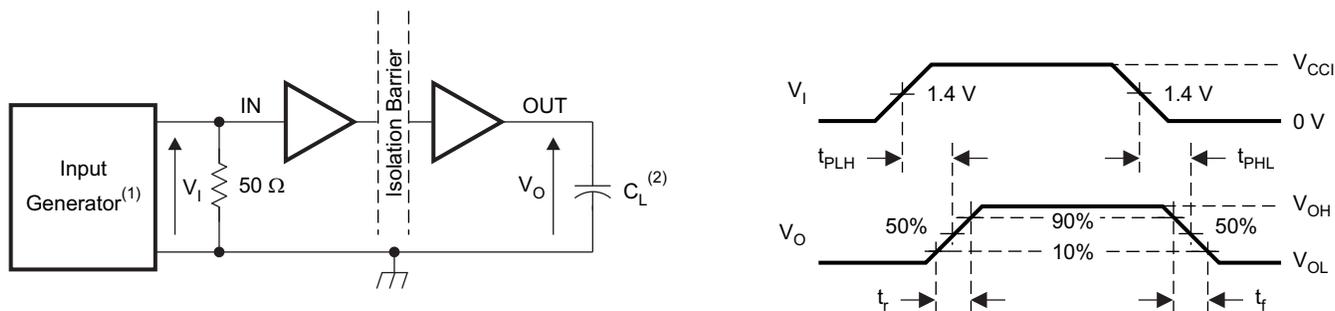
15 Switching Characteristics

 V_{CC1} and V_{CC2} at 3.3 V \pm 5%, $T_A = -40^\circ\text{C}$ to 125°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	See 图 1		12	20	ns
PWD ⁽¹⁾	Pulse width distortion $ t_{PHL} - t_{PLH} $			1	5	ns
$t_{sk(pp)}$	Part-to-part skew time				6.8	ns
$t_{sk(o)}$	Channel-to-channel output skew time				5.5	ns
t_r	Output signal rise time	See 图 1		2		ns
t_f	Output signal fall time			2		ns
t_{fs}	Fail-safe output delay time from input power loss	See 图 2		6		μs

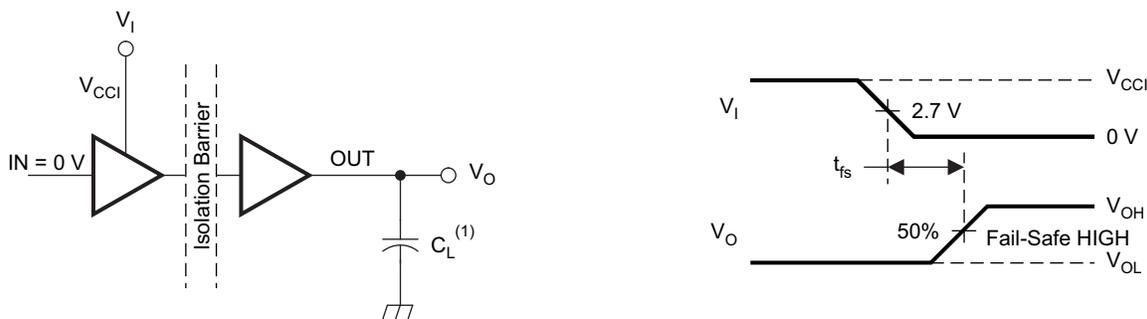
(1) Also known as pulse skew.

16 Parameter Measurement Information



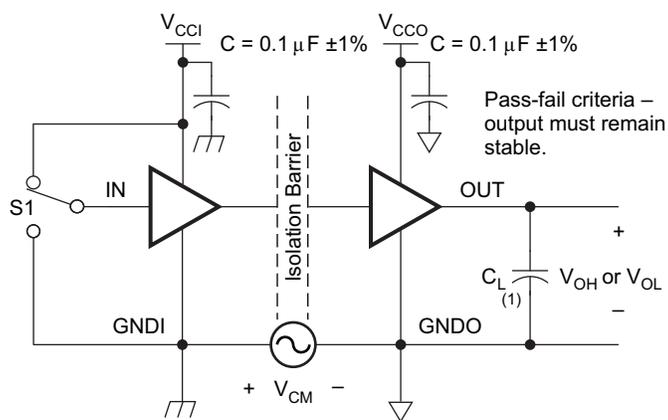
- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3ns, $t_f \leq$ 3ns, $Z_O = 50\Omega$.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

图 1. Switching Characteristic Test Circuit and Voltage Waveforms



- A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

图 2. Failsafe Delay Time Test Circuit and Voltage Waveforms



- A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

图 3. Common-Mode Transient Immunity Test Circuit

17 Device Information

17.1 Package Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal to terminal distance through air	7.6			mm
L(I02)	Minimum external tracking (Creepage)	Shortest terminal to terminal distance across the package surface	7.6			mm
CTI	Tracking resistance (Comparative Tracking Index)	DIN EN 60112 (VDE 0303-11)	≥400			V
	Minimum internal gap (Internal Clearance)	Distance through the insulation	0.014			mm
R _{IO}	Isolation resistance, input to output ⁽¹⁾	Input to output, V _{IO} = 500 V, all pins on each side of the barrier tied together creating a two-terminal device		>10 ¹²		Ω
C _{IO}	Barrier capacitance input to output ⁽¹⁾	V _{IO} = 0.4 sin(2πft), f = 1 MHz		2		pF
C _I	Input capacitance to ground ⁽²⁾	V _I = V _{CC} /2 + 0.4 sin(2πft), f = 1 MHz, V _{CC} = 5 V		2		pF

(1) All pins on each side of the barrier tied together creating a two-terminal device.

(2) Measured from input pin to ground.

注

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board do not reduce this distance

Creepage and clearance on a printed circuit board become equal according to the measurement techniques shown in the Isolation Glossary. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

17.2 IEC 60664-1 Ratings Table

PARAMETER	TEST CONDITIONS	SPECIFICATION
Basic Isolation Group	Material Group	II
Installation Classification	Rated mains voltages ≤ 150 Vrms	I - IV
	Rated mains voltages ≤ 300 Vrms	I - IV
	Rated mains voltages ≤ 400 Vrms	I - III

17.3 Insulation Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	SPECIFICATION	UNIT
V _{IORM}	Maximum working insulation voltage		1414	V _{peak}
V _{PR}	Input to output test voltage	Method a, After environmental tests subgroup 1, V _{PR} = V _{IORM} × 1.6, t = 10 s, Partial discharge < 5 pC	2262	V _{peak}
		After Input/Output Safety Test Subgroup 2/3, V _{PR} = V _{IORM} × 1.2, t = 10 s, Partial discharge < 5 pC	1697	
		Method b1, V _{PR} = V _{IORM} × 1.875, t = 1 s (100% Production test) Partial discharge < 5 pC	2651	
V _{IOTM}	Transient overvoltage	t = 60 sec (qualification)	4242	V _{peak}
V _{ISO}	Isolation voltage per UL	V _{TEST} = V _{ISO} , t = 60 sec (qualification)	2500	V _{rms}
		V _{TEST} = 1.2 × V _{ISO} , t = 1 sec (100% production)	3000	
R _S	Insulation resistance	V _{TEST} = 500 V at T _S = 150°C	>10 ⁹	Ω
	Pollution degree		2	

17.4 Regulatory Information

VDE	CSA	UL
Certified according to DIN VDE V 0884-11:2017-01	Approved according to IEC 60950-1 and IEC 61010-1	Recognized under UL 1577 Component Recognition Program
Certificate Number: 40047657	Master Contract Number: 220991	File Number: E181974

17.5 IEC Safety Limiting Values

Safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the IO can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _S	Safety input, output, or supply current	θ _{JA} = 212°C/W, V _I = 5.5 V, T _J = 170°C, T _A = 25°C			112	mA
		θ _{JA} = 212°C/W, V _I = 3.6 V, T _J = 170°C, T _A = 25°C			171	
T _S	Maximum Case Temperature				150	°C

The safety-limiting constraint is the absolute maximum junction temperature specified in the absolute maximum ratings table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the Thermal Characteristics table is that of a device installed on a High-K Test Board for Leaded Surface Mount Packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.

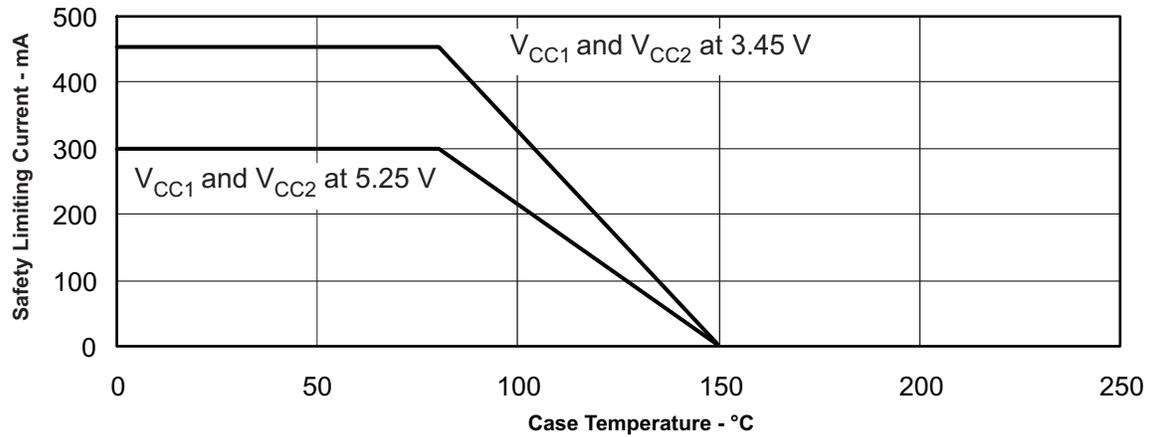


图 4. DW-16 Theta-JC Thermal Derating Curve per IEC 60747-5-2

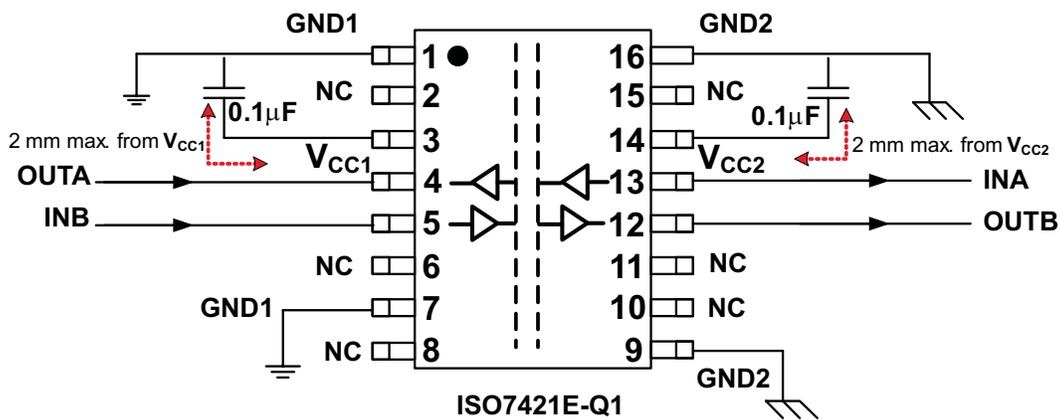


图 5. Typical ISO7421E-Q1 Application Circuit

17.6 Equivalent Input And Output Schematic Diagrams

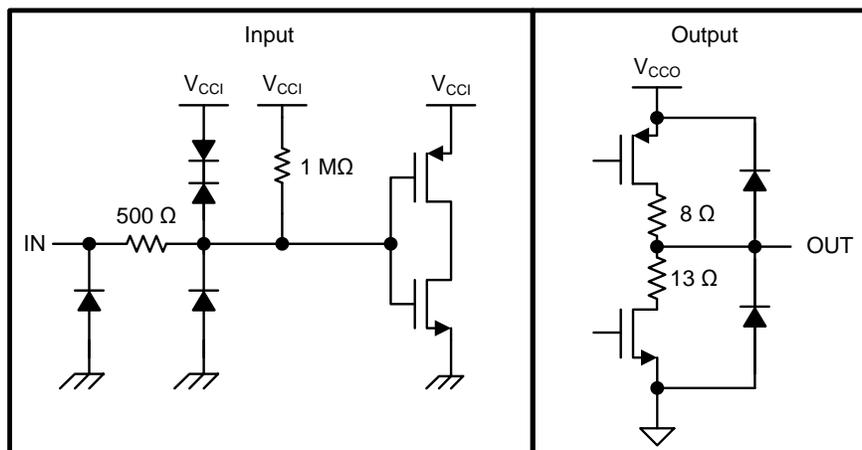


图 6. I/O Schematic

18 Typical Characteristics

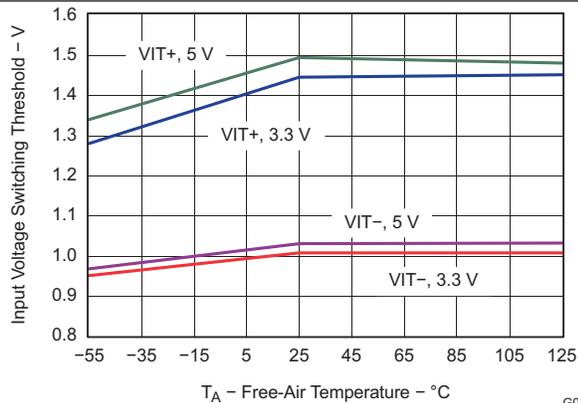


图 7. Input Voltage Switching Threshold Vs Free-air Temperature

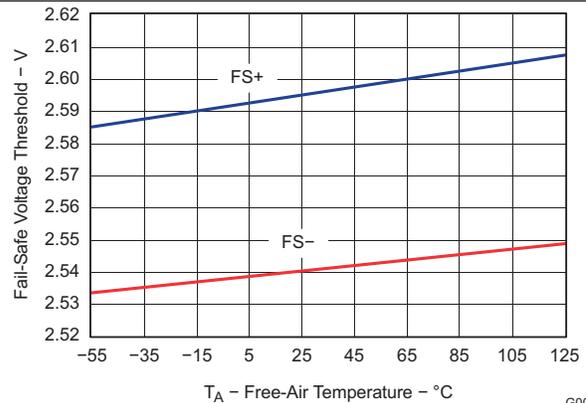


图 8. Fail-safe Voltage Threshold Vs Free-air Temperature

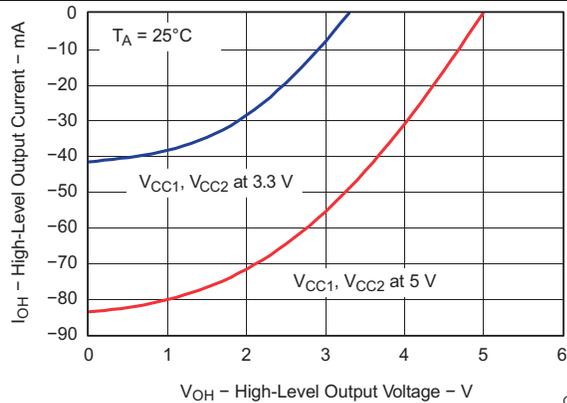


图 9. High-level Output Current Vs High-level Output Voltage

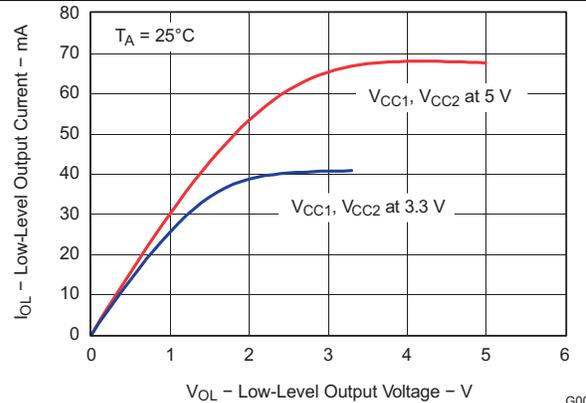


图 10. Low-level Output Current Vs Low-level Output Voltage

19 Revision History

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision B (May 2012) to Revision C	Page
• 删除了 特性 项目符号“宽环境温度：-40°C 至 125°C”，因为涉及重复	1
• 将 特性 项目符号从“符合 VDE 标准的 4kV 峰值最大隔离，符合 UL 1577 标准的 2.5kVrms 隔离，通过 IEC 60950-1 和 IEC 61010-1 终端设备标准验证的 CSA。所有审批待定。”更改为“符合 VDE 标准的 4242V _{PK} 隔离，符合 UL 1577 标准的 2.5kVrms 隔离，通过 IEC 60950-1 和 IEC 61010-1 终端设备标准验证的 CSA”	1
• 将“ISO7421E-Q1 可提供双通道电隔离...”更改为“ISO7421E-Q1 可提供电隔离...”，改动位置在说明部分	1
• 添加了器件的简化原理图	1
• Changed column titles From:"INPUT SIDE (VCC)" To:"INPUT SIDE V _{CC} (V _{CCI})" and From:"OUTPUT SIDE (VCC)" To:"OUTPUT SIDE V _{CC} (V _{CCO})" in Device Function Table	3
• Changed MAX VALUE for V _I From: "6 V" To: "V _{CC} + 0.5 V"	3
• Added : "Maximum voltage must not exceed 6 V. A strongly driven input signal can weakly power the floating V _{CC} via an internal protection diode and cause undetermined output."	3
• Deleted Supply Current parameters with V _{CC1} and V _{CC2} at 5 V ± 5% for ISO7420x in Electrical Characteristics table since ISO7420x is not included in the data sheet.	5
• Deleted Supply Current parameters with V _{CC1} at 5 V ± 5%, V _{CC2} at 3.3 V ± 5% for ISO7420x in Electrical Characteristics table since ISO7420x is not included in the data sheet.	6
• Deleted Supply Current parameters with V _{CC1} at 3.3 V ± 5%, V _{CC2} at 5 V ± 5% for ISO7420x in Electrical Characteristics table since ISO7420x is not included in the data sheet.	7
• Deleted Supply Current parameters with V _{CC1} and V _{CC2} at 3.3 V ± 5% for ISO7420x in Electrical Characteristics table since ISO7420x is not included in the data sheet.	8
• Changed V _{CC1} to V _{CCI} and V _{CC2} to 50% in 图 1	9
• Changed V _{CC1} to V _{CCI} and IN From:"0V or V _{CC1} " To:"0 V" in 图 2	9
• Corrected 'Ground' symbols on both sides of the Isolation Barrier in 图 3	9
• Changed MIN specification for Clearance or L(I01) From: "8.34 mm" To:"7.6 mm" in Package Characteristics table.	10
• Changed MIN specification for Creepage or L(I02) From: "8.1 mm" To:"7.6 mm" in Package Characteristics table.	10
• Changed CTI TEST CONDITIONS From: " DIN IEC 60112 / VDE 0303 Part 1" To: "DIN EN 60112 (VDE 0303-11)"	10
• Added "V _{TEST} = 1.2 x V _{ISO} " to V _{ISO} parameter TEST CONDITIONS in Insulation Characteristics table	11
• Changed VDE standard name From: "IEC 60747-5-2" To:"DIN VDE V 0884-11:2017-01" and document reference From:"File Number: Pending" To:"Certificate Number: 40047657" respectively in Regulatory Information table.....	11
• Changed CSA standard reference From:"Approved under CSA Component Acceptance Notice" To:"Approved according to IEC 60950-1 and IEC 61010-1" and document reference From: "File Number: pending" To:"Master Contract Number: 220991" respectively in Regulatory Information table.....	11
• Changed UL standard reference From:"1577" To:"UL 1577" in Regulatory Information table.	11
• Changed ground symbol of 'Output' to differentiate it from 'Input' in 图 6	12

Changes from Revision A (March 2012) to Revision B	Page
• 将信号传输速率信息从 1Mbps 更改为 50Mbps	1
• Changed Signaling rate max value from 1 to 50 Mbps, centered 0 in the min column.	4
• Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 8.5 max value to 9.1.	5
• Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 8.5 max value to 9.1 and changed 5.5 max value to 5.8.	6
• Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 5.5 max value to 5.8 and changed 8.5 max value to 9.1.	7
• Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 5.5 max value to 5.8.	8

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
ISO7421EQDWRQ1	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	ISO7421EQ
ISO7421EQDWRQ1.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	ISO7421EQ

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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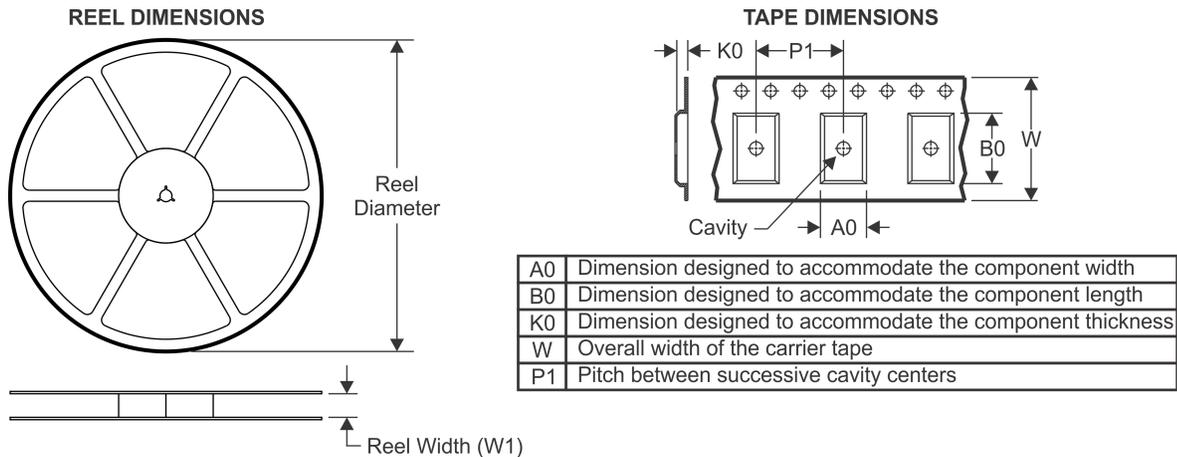
OTHER QUALIFIED VERSIONS OF ISO7421E-Q1 :

- Catalog : [ISO7421E](#)

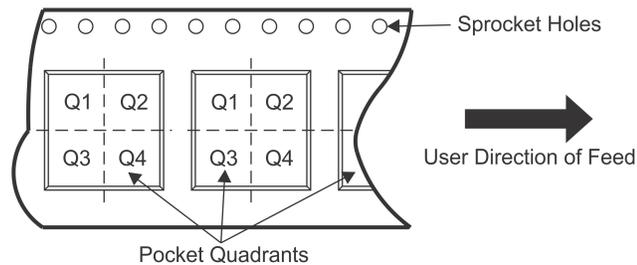
NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION



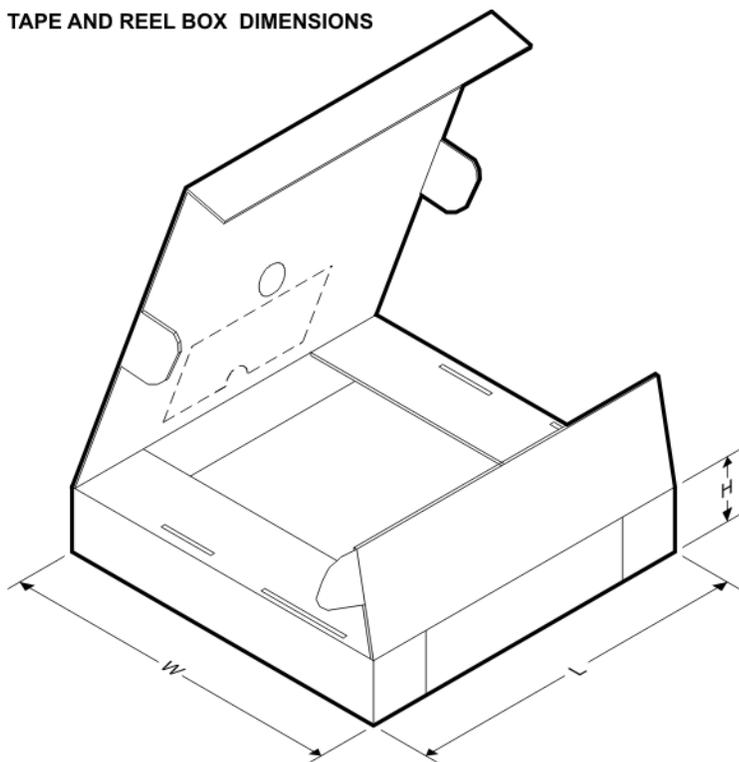
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7421EQDWRQ1	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7421EQDWRQ1	SOIC	DW	16	2000	350.0	350.0	43.0

GENERIC PACKAGE VIEW

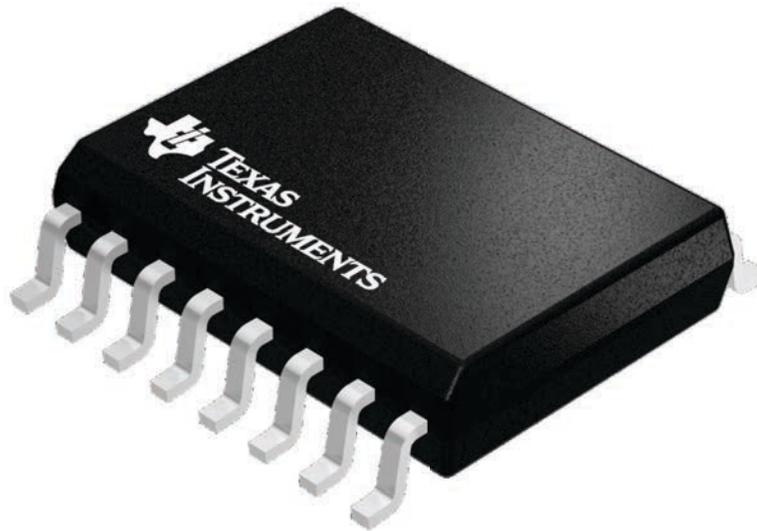
DW 16

SOIC - 2.65 mm max height

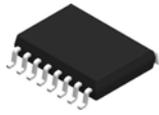
7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



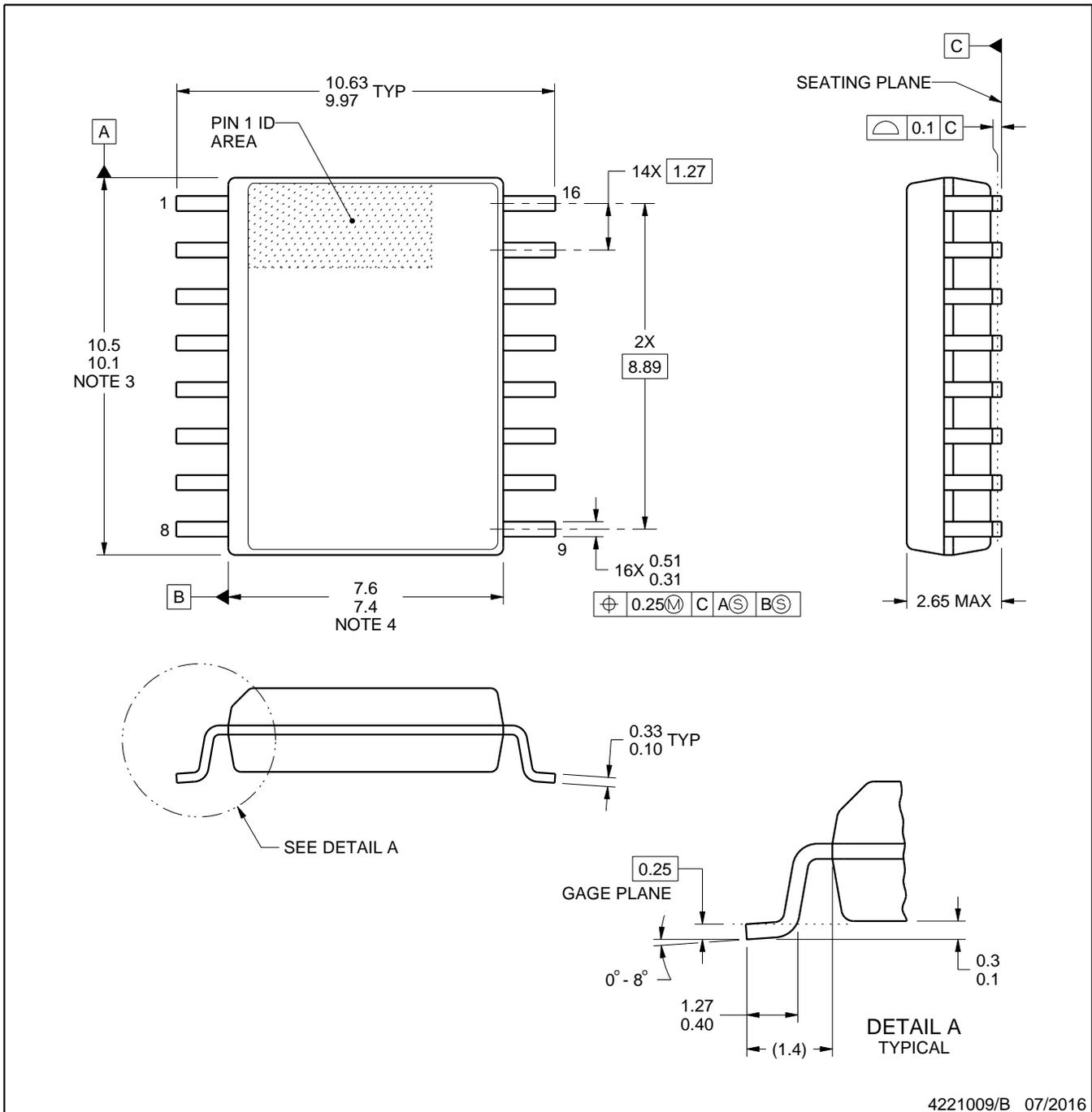
4224780/A



DW0016B

PACKAGE OUTLINE SOIC - 2.65 mm max height

SOIC



4221009/B 07/2016

NOTES:

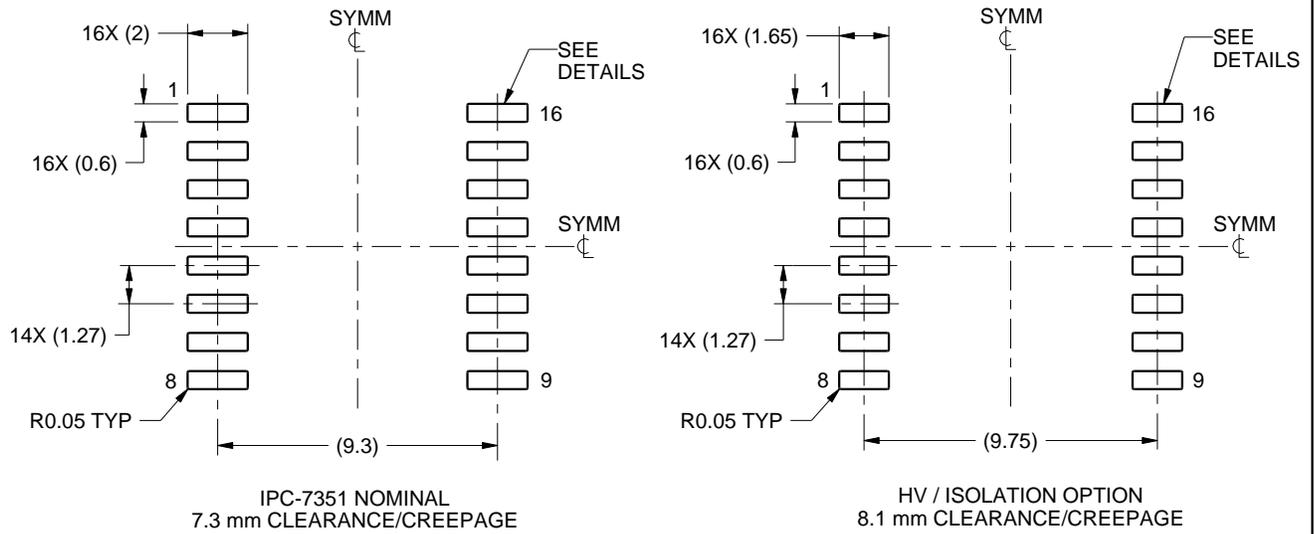
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.

EXAMPLE BOARD LAYOUT

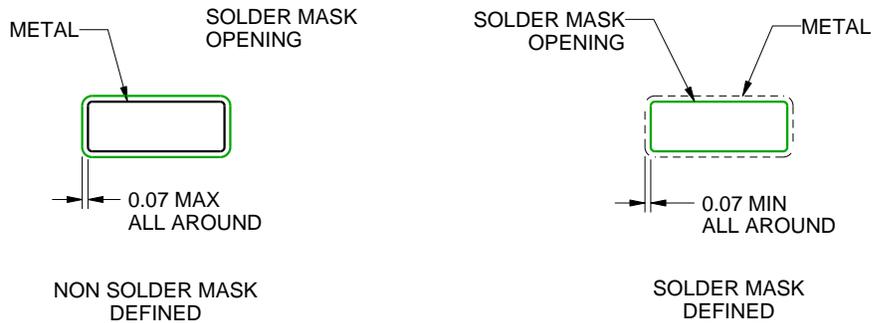
DW0016B

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE
SCALE:4X



SOLDER MASK DETAILS

4221009/B 07/2016

NOTES: (continued)

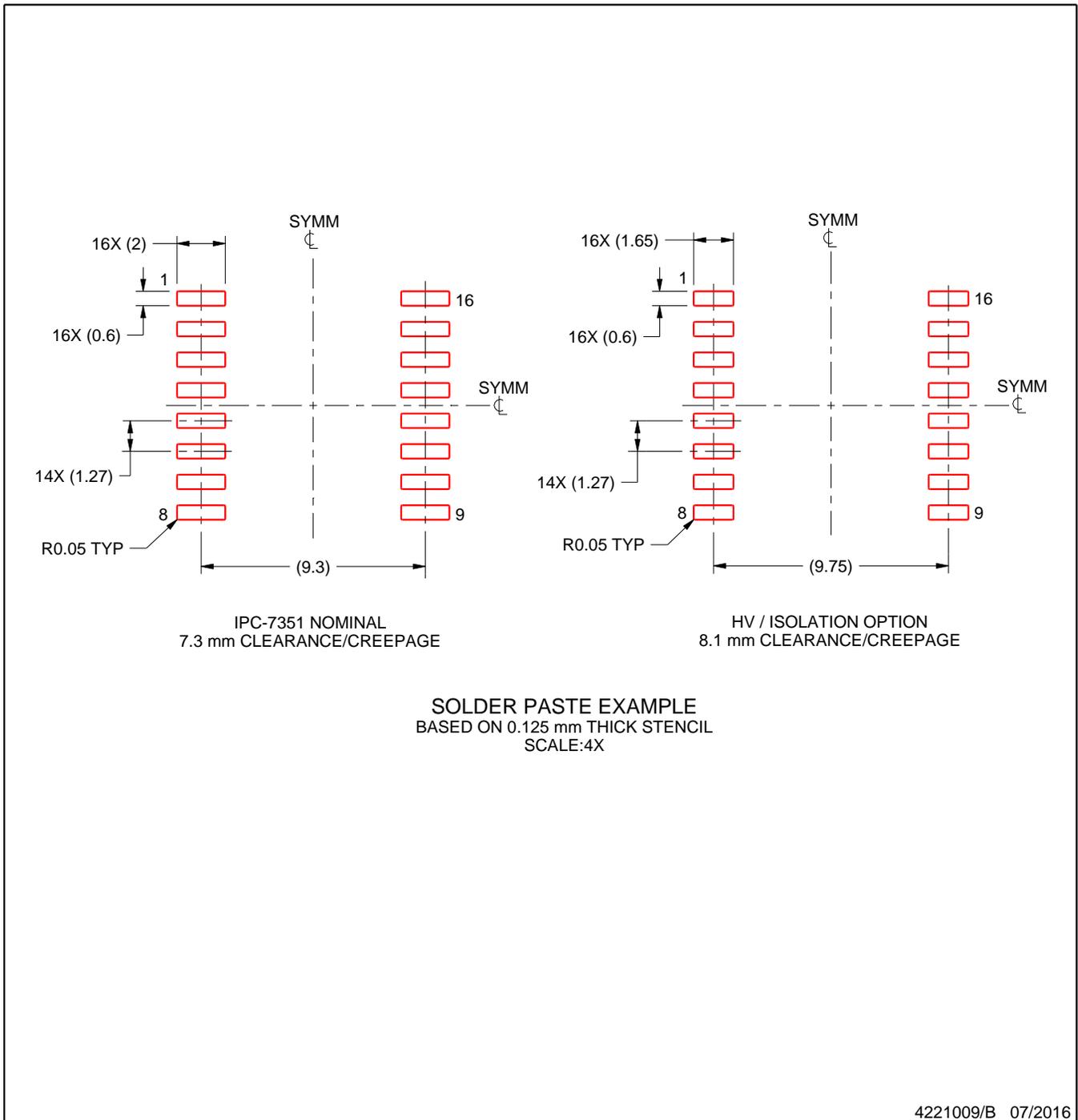
- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DW0016B

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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最后更新日期：2025 年 10 月